Low Noise, High Speed Precision Operational Amplifiers

FEATURES

- *Guaranteed* 3.8nV/√Hz *max* 1kHz Noise
- *Guaranteed* 5.5nV/√Hz *max* 10Hz Noise
- Very Low Peak-to-Peak Noise, 80nV Typical
- *Guaranteed* 25µV *max* Offset Voltage
- *Guaranteed* 0.6µV/°C *max* Drift with Temperature
- *Guaranteed* 11V/µsec *min* Slew Rate (OP-37)
- *Guaranteed* 1 Million *min* Voltage Gain

APPLICATIONS

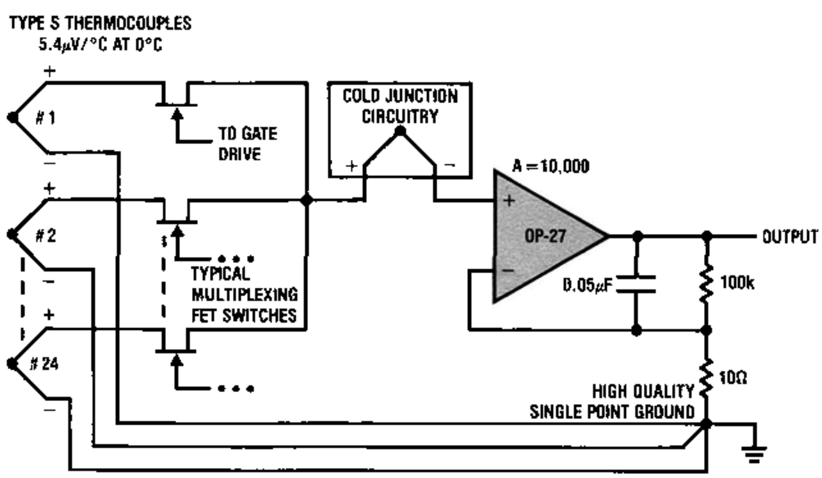
- Low Level Transducer Amplifiers
- Precision Threshold Detectors
- Tape Head Preamplifiers
- Microphone Preamplifiers
- Direct Coupled Audio Gain Stages

DESCRIPTION

The OP-27/OP-37 series of operational amplifiers combine outstanding noise performance with excellent precision and high speed specifications. The wideband noise is only 3nV/√Hz, and with the 1/f noise corner at 2.7Hz, low noise is maintained for all low frequency instrumentation applications. Precision DC specifications match or exceed the best available op amps: offset voltage is 10µV, drift with temperature and time are 0.2µV/°C and 0.2µV/month, respectively; common mode rejection is 126dB, voltage gain is two million. The unity gain compensated OP-27 is an order of magnitude faster than other precision op amps. The decompensated OP-37 is even faster at a gain-bandwidth product of 63MHz and 17V/µsec slew rate. These characteristics plus Linear Technology's advanced process and test techniques make the OP-27/37 an excellent choice for performance and reliability in all low noise, precision amplifier applications. In addition, Linear's OP-37 is completely latch-up free in high gain, large capacitive feedback configurations. The accurate, microvolt, low noise signal handling capabilities of the OP-27/37 are taken advantage of in the multiplexed thermocouple application shown.

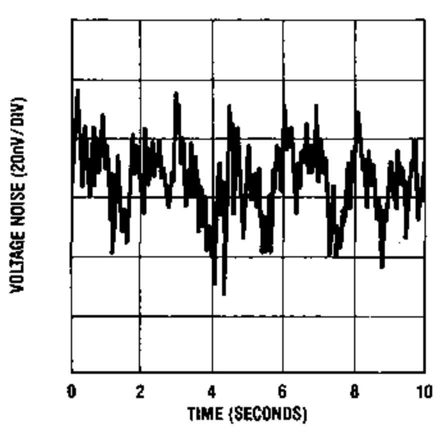
For applications requiring higher performance, see the LT1007 and LT1037 data sheets.

Low Noise, Multiplexed Thermocouple Amplifier



If 24 channels are multiplexed per second, and the output is required to settle to 0.1% accuracy, the amplifier's bandwidth cannot be limited to less than 30Hz. Yet the noise contribution of the OP-27 will still be only 0.11µVp-p, which is equivalent to an error of only 0.02°C.

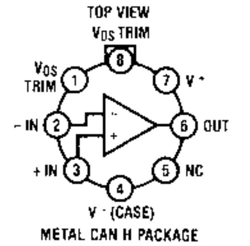
0.1Hz to 10Hz Noise



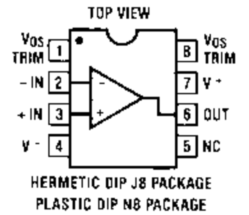
ABSOLUTE MAXIMUM RATINGS

Supply Voltage .... ± 22V
Internal Power Dissipation 500mW
Input Voltage .... Equal to Supply Voltage
Output Short Circuit Duration .... Indefinite
Differential Input Current (Note 8) .... ± 25mA
Lead Temperature (Soldering, 10 sec.) .... 300°C
Operating Temperature Range
OP-27/OP-37 A, C .... – 55°C to 125°C
OP-27/OP-37 E, G .... – 25°C to 85°C
Junction Temperature Range
OP-27/OP-37 A, C .... – 55°C to 150°C
OP-27/OP-37 E, G .... – 25°C to 125°C
Storage Temperature Range
OP-27/OP-37 A, C, E, G .... – 65°C to 150°C

PACKAGE/ORDER INFORMATION



ORDER PART NUMBER	
OBSOLETE PACKAGE	
OP-27AH	OP-37AH
OP-27CH	OP-37CH
OP-27EH	OP-37EH
OP-27GH	OP-37GH



OP-27AJ8	OP-37EJ8
OP-27CJ8	OP-37GJ8
OP-27EJ8	OP-27EN8
OP-27GJ8	OP-27GN8
OP-37AJ8	OP-37EN8
OP-37CJ8	OP-37GN8

ELECTRICAL CHARACTERISTICS $V_S = \pm 15V$, $T_A = 25°C$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	OP-27A,E/OP-37A,E MIN	TYP	MAX	OP-27C,G/OP-37C,G MIN	TYP	MAX	UNITS
V_{OS}	Input Offset Voltage	(Note 1)		10	25		30	100	µV
$\frac{\Delta V_{OS}}{\Delta Time}$	Long Term Offset Voltage Stability	(Note 2)		0 2	1 0		0 4	2 0	µV/Mo
I_{OS}	Input Offset Current			7	35		12	75	nA
I_B	Input Bias Current			± 10	± 40		± 15	± 80	nA
e_n	Input Noise Voltage	0 1Hz to 10Hz (Notes 3 and 5)		0 08	0 18		0 09	0 25	µVp-p
	Input Noise Voltage Density	f_0 = 10Hz (Note 3) f_0 = 30Hz (Note 3) f_0 = 1000Hz (Note 3)		3 5 3 1 3 0	5 5 4 5 3 8		3 8 3 3 3 2	8 0 5 6 4 5	nV/√Hz nV/√Hz nV/√Hz
i_n	Input Noise Current Density	f_0 = 10Hz (Notes 3 and 6) f_0 = 30Hz (Notes 3 and 6) f_0 = 1000Hz (Notes 3 and 6)		1 7 1 0 0 4	4 0 2 3 0 6		1 7 1 0 0.4	 0 6	pA/√Hz pA/√Hz pA/√Hz
	Input Resistance—Common Mode			3			2		GΩ
	Input Voltage Range		± 11 0	± 12 3		± 11 0	± 12 3		V
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 11V$	114	126		100	120		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 4V$ to $\pm 18V$	100	120		94	118		dB
A_{VOL}	Large Signal Voltage Gain	$R_L \geq 2k\Omega$, $V_O = \pm 10V$ $R_L \geq 1k\Omega$, $V_O = \pm 10V$ $R_L = 600\Omega$, $V_O = \pm 1V$ $V_S = \pm 4V$ (Note 4)	1000 800 250	1800 1500 700		700 200	1500 1500 500		V/mV V/mV V/mV
V_{OUT}	Maximum Output Voltage Swing	$R_L \geq 2k\Omega$ $R_L \geq 600\Omega$	± 12 0 ± 10 0	± 13 8 ± 11 5		± 11 5 ± 10 0	± 13.5 ± 11 5		V V
SR	Slew Rate OP-27 OP-37	$R_L \geq 2k\Omega$ (Note 4) $A_{VCL} \geq 5$ (Note 4)	1 7 11	2 8 17		1 7 11	2 8 17		V/µs V/µs
GBW	Gain-Bandwidth OP-27 Product OP-37	f_0 = 100kHz (Note 4) f_0 = 10kHz (Note 4) f_0 = 1MHz ($A_{VCL} \geq 5$)	5 0 45	8 0 63 40		5 0 45	8 0 63 40		MHz MHz MHz
Z_O	Open Loop Output Resistance	$V_O = 0$, $I_O = 0$		70			70		Ω
P_d	Power Dissipation			90	140		100	170	mW

ELECTRICAL CHARACTERISTICS $V_S = \pm 15V$, $-55°C \le T_A \le 125°C$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS		OP-27A/OP-37A MIN	OP-27A/OP-37A TYP	OP-27A/OP-37A MAX	OP-27C/OP-37C MIN	OP-27C/OP-37C TYP	OP-27C/OP-37C MAX	UNITS
V_{OS}	Input Offset Voltage	(Note 1)	●		30	60		70	300	μV
$\frac{\Delta V_{OS}}{\Delta Temp}$	Average Input Offset Drift	(Note 7)	●		0.2	0.6		0.4	1.8	μV/°C
I_{OS}	Input Offset Current		●		15	50		30	135	nA
I_B	Input Bias Current		●		±20	±60		±35	±150	nA
	Input Voltage Range		●	±10.3	±11.5		±10.2	±11.5		V
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 10V$	●	108	122		94	116		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 4.5V$ to $\pm 18V$	●	96	116		86	110		dB
A_{VOL}	Large Signal Voltage Gain	$R_L \ge 2k\Omega$, $V_O = \pm 10V$	●	600	1200		300	800		V/mV
V_{OUT}	Maximum Output Voltage Swing	$R_L \ge 2k\Omega$	●	±11.5	±13.5		±10.5	±13.0		V

ELECTRICAL CHARACTERISTICS $V_S = \pm 15V$, $-25°C \le T_A \le 85°C$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS		OP-27E/OP-37E MIN	OP-27E/OP-37E TYP	OP-27E/OP-37E MAX	OP-27G/OP-37G MIN	OP-27G/OP-37G TYP	OP-27G/OP-37G MAX	UNITS
V_{OS}	Input Offset Voltage	(Note 1)	●		20	50		55	220	μV
$\frac{\Delta V_{OS}}{\Delta Temp}$	Average Input Offset Drift	(Note 7)	●		0.2	0.6		0.4	1.8	μV/°C
I_{OS}	Input Offset Current		●		10	50		20	135	nA
I_B	Input Bias Current		●		±14	±60		±25	±150	nA
	Input Voltage Range		●	±10.5	±11.8		±10.5	±11.8		V
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 10V$	●	110	124		96	118		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 4.5V$ to $\pm 18V$	●	97	118		90	114		dB
A_{VOL}	Large Signal Voltage Gain	$R_L \ge 2k\Omega$, $V_O = \pm 10V$	●	750	1500		450	1000		V/mV
V_{OUT}	Maximum Output Voltage Swing	$R_L \ge 2k\Omega$	●	±11.7	±13.6		±11.0	±13.3		V

The ● denotes the specifications which apply over full operating temperature range.

Note 1: Input Offset Voltage measurements are performed by automatic test equipment approximately 0.5 seconds after application of power. A and E grades are guaranteed fully warmed up.

Note 2: Long Term Input Offset Voltage Stability refers to the average trend line of Offset Voltage vs Time over extended periods after the first 30 days of operation. Excluding the initial hour of operation, changes in V_{OS} during the first 30 days are typically 2.5μV—refer to typical performance curve.

Note 3: Sample tested. Contact factory for 100% testing of 10Hz voltage noise.

Note 4: Parameter is guaranteed by design and is not tested.

Note 5: See test circuit and frequency response curve for 0.1Hz to 10Hz tester in Applications Information section.

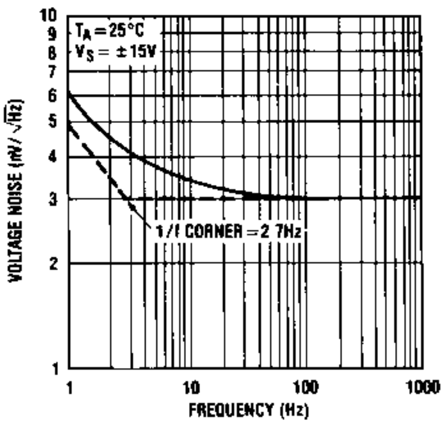
Note 6: See test circuit for current noise measurement in Applications Information section.

Note 7: The Average Input Offset Drift performance is within the specifications unnulled or when nulled with a pot having a range of 8kΩ to 20kΩ.

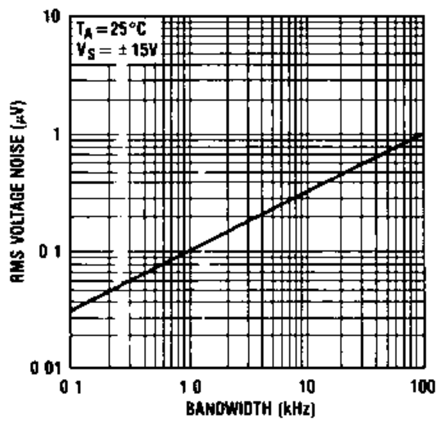
Note 8: The OP-27/37's inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise. If differential input voltage exceeds ±0.7V, the input current should be limited to 25mA.

TYPICAL PERFORMANCE CHARACTERISTICS

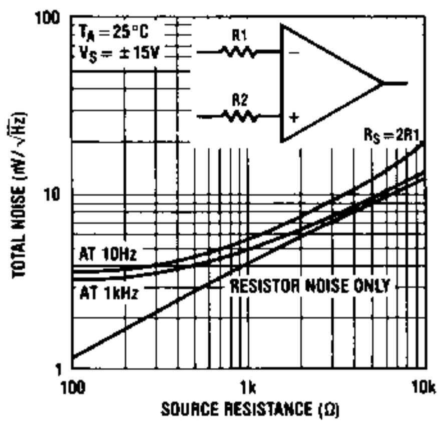
Voltage Noise vs Frequency



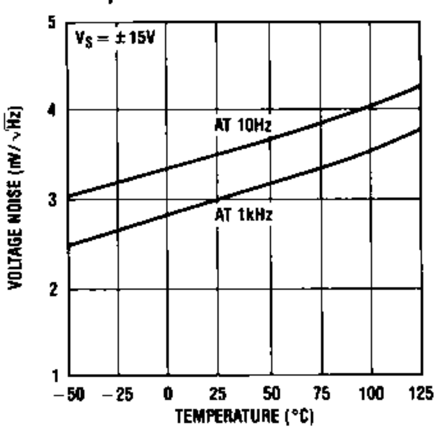
Input Wideband Voltage Noise vs Bandwidth (0.1Hz to Frequency Indicated)



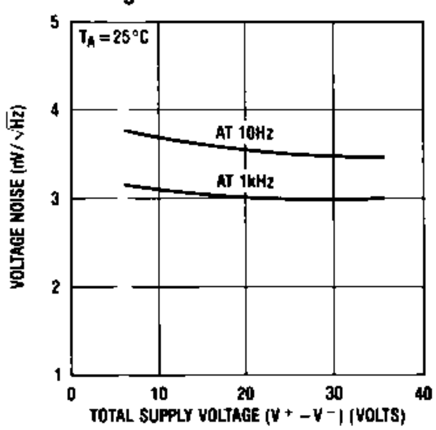
Total Noise vs Source Resistance



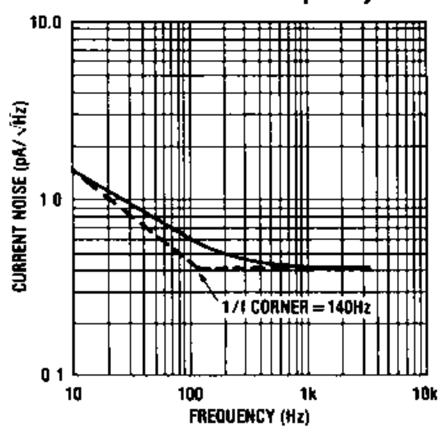
Voltage Noise vs Temperature



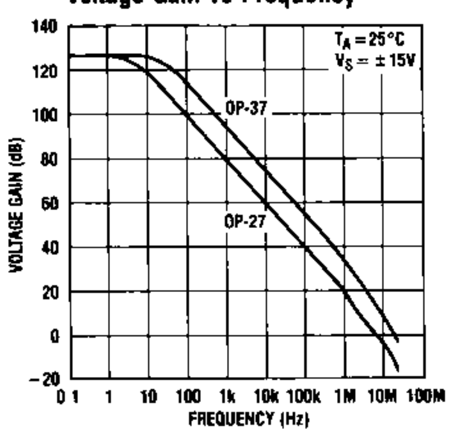
Voltage Noise vs Supply Voltage



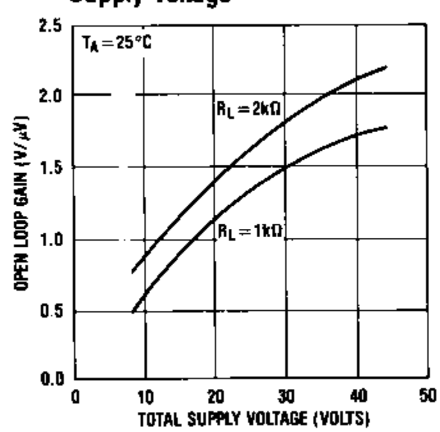
Current Noise vs Frequency



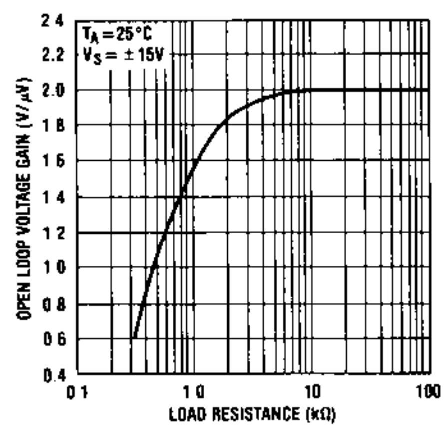
Voltage Gain vs Frequency



Open Loop Voltage Gain vs Supply Voltage

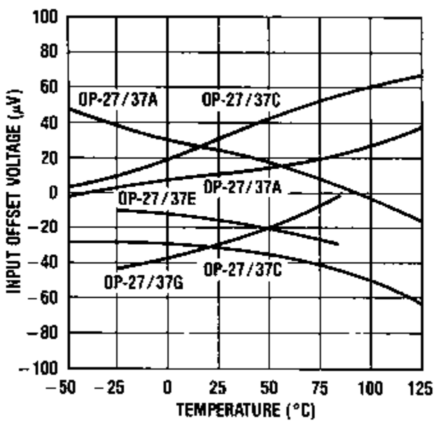


Open Loop Voltage Gain vs Load Resistance

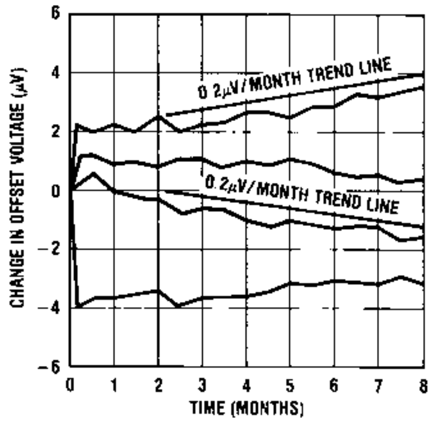


TYPICAL PERFORMANCE CHARACTERISTICS

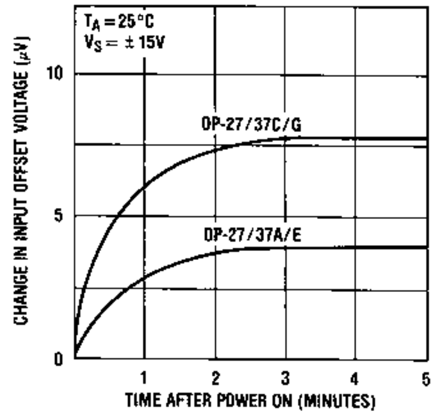
Offset Voltage Drift of Representative Units



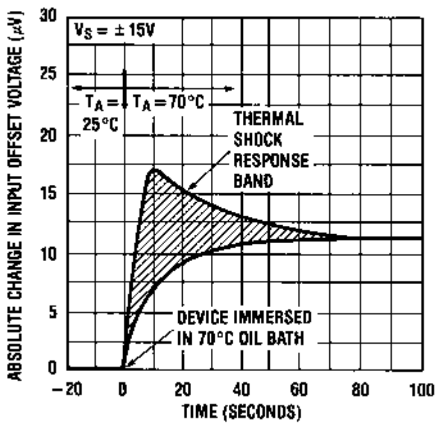
Long Term Drift of Representative Units



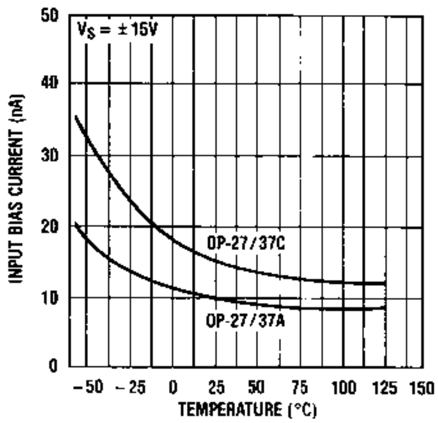
Warm-Up Drift



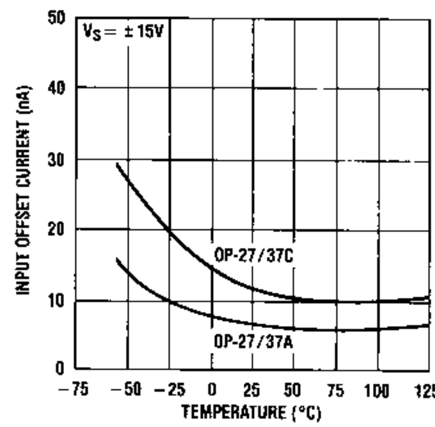
Offset Voltage Change Due to Thermal Shock



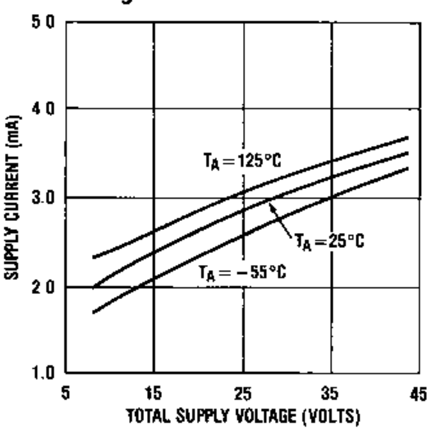
Input Bias Current vs Temperature



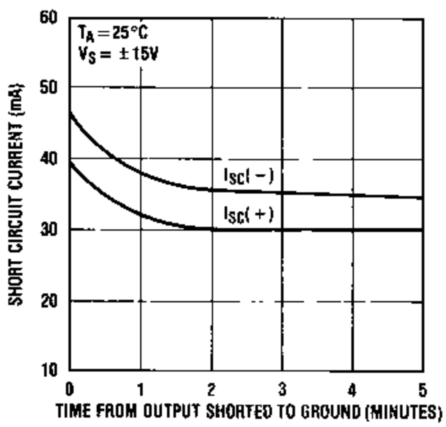
Input Offset Current vs Temperature



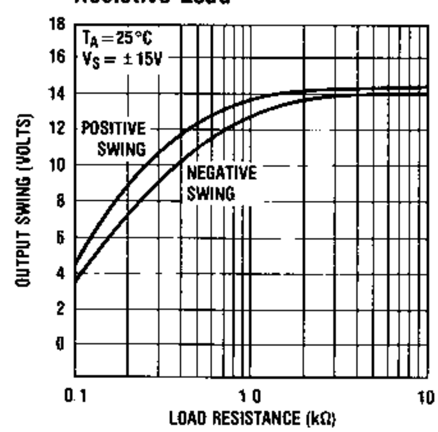
Supply Current vs Supply Voltage



Short Circuit Current vs Time

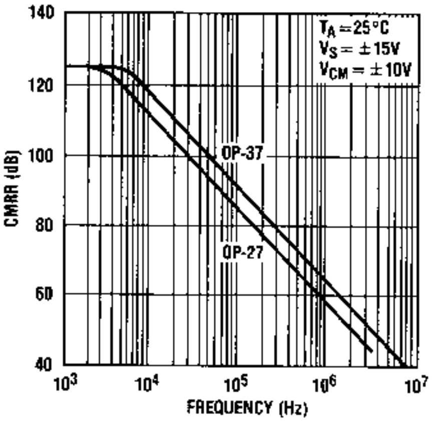


Maximum Output Swing vs Resistive Load

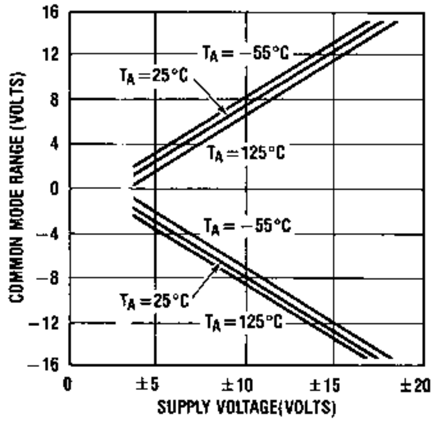


TYPICAL PERFORMANCE CHARACTERISTICS

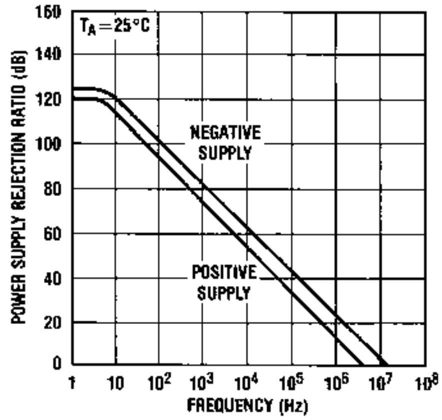
Common Mode Rejection vs Frequency



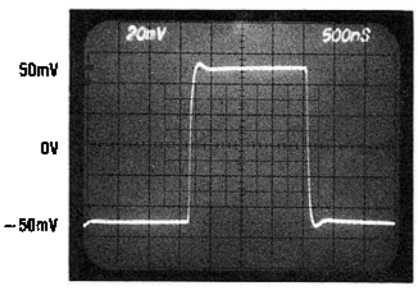
Common Mode Input Range vs Supply Voltage



PSRR vs Frequency

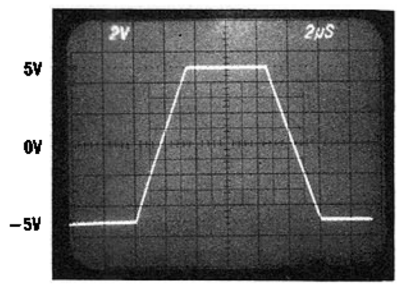


OP-27 Small Signal Transient Response



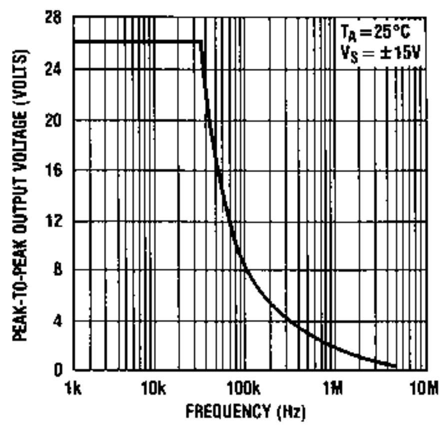
$A_{VCL} = +1$, $V_S = \pm 15V$
$C_L = 15pF$

OP-27 Large Signal Transient Response

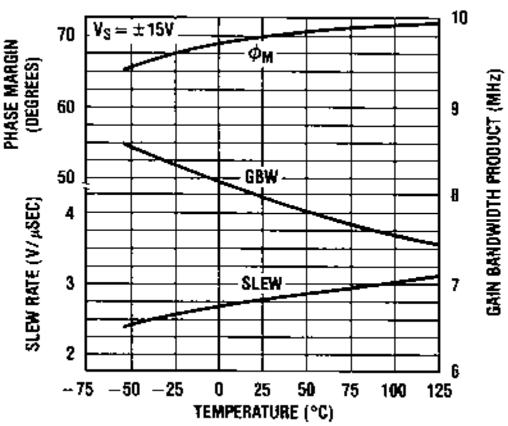


$A_{VCL} = -1$, $V_S = \pm 15V$

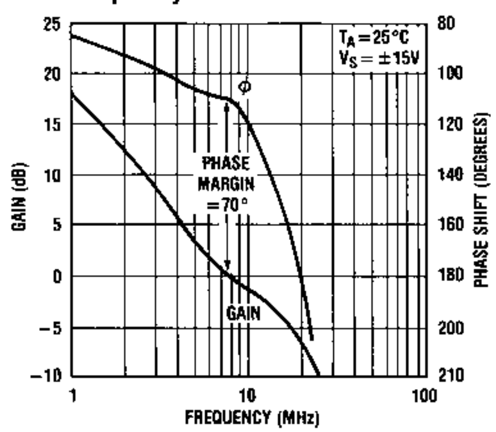
OP-27 Maximum Undistorted Output vs Frequency



OP-27 Slew Rate, Gain Bandwidth Product, Phase Margin vs Temperature

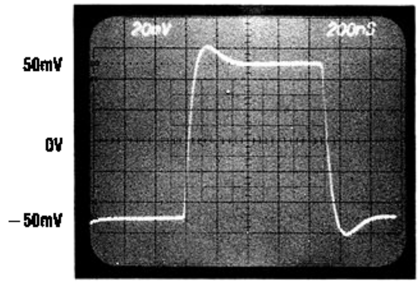


OP-27 Gain, Phase Shift vs Frequency



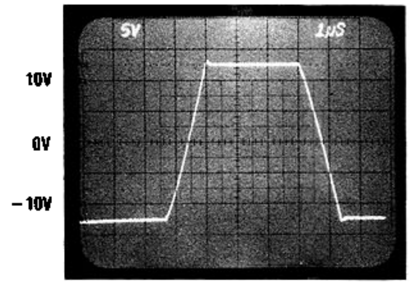
TYPICAL PERFORMANCE CHARACTERISTICS

OP-37 Small Signal Transient Response



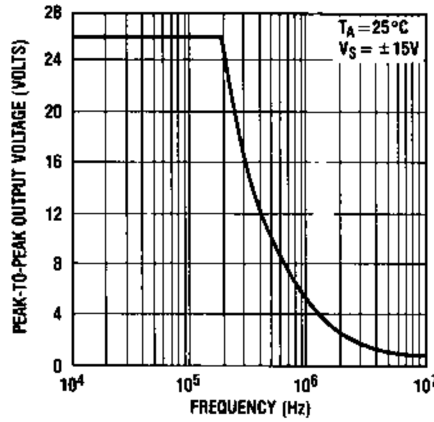
$A_{VCL}=+5$, $V_S=\pm15V$
$C_L=15pF$

OP-37 Large Signal Response

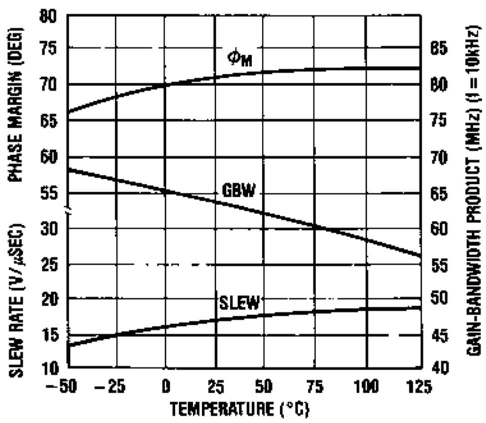


$A_{VCL}=+5$, $V_S=\pm15V$

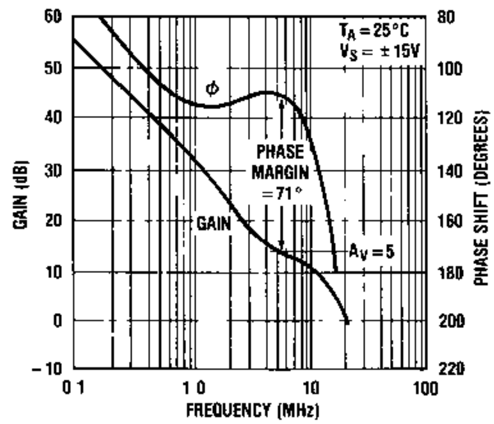
OP-37 Maximum Undistorted Output vs Frequency



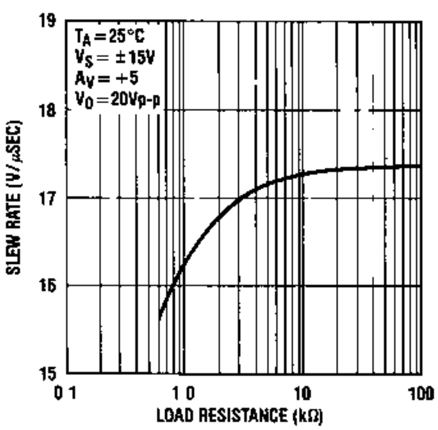
OP-37 Slew Rate, Gain Bandwidth Product, Phase Margin vs Temperature



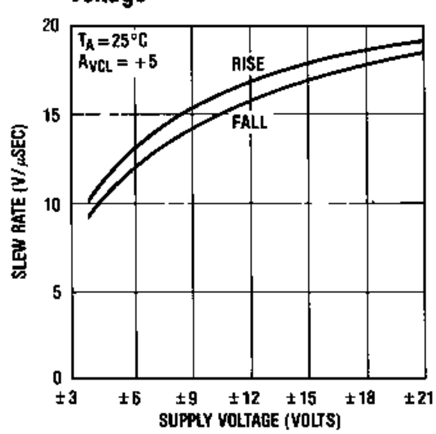
OP-37 Gain, Phase Shift vs Frequency



OP-37 Slew Rate vs Load



OP-37 Slew Rate vs Supply Voltage



APPLICATIONS INFORMATION

General

The OP-27/37 series devices may be inserted directly into OP-07, OP-05, 725, and 5534 sockets with or without removal of external compensation or nulling components. In addition, the OP-27/37 may be fitted to 741 sockets with the removal or modification of external nulling components.

Noise Testing

The 0.1Hz to 10Hz peak-to-peak noise of the OP-27/OP-37 is measured in the test circuit shown. The frequency response of this noise tester indicates that the 0.1Hz corner is defined by only one zero. The test time to measure 0.1Hz to 10Hz noise should not exceed 10 seconds, as this time limit acts as an additional zero to eliminate noise contributions from the frequency band below 0.1Hz.

Measuring the typical 80nV peak-to-peak noise performance of the OP-27/37 requires special test precautions:

(a) The device should be warmed up for at least five minutes. As the op amp warms up, its offset voltage changes typically 4μV due to its chip temperature increasing 10°C to 20°C from the moment the power supplies are turned on. In the 10 second measurement interval these temperature-induced effects can easily exceed tens of nanovolts.

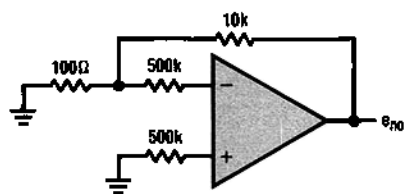
(b) For similar reasons, the device must be well shielded from air currents to eliminate the possibility of thermoelectric effects in excess of a few nanovolts, which would invalidate the measurements.

(c) Sudden motion in the vicinity of the device can also "feedthrough" to increase the observed noise.

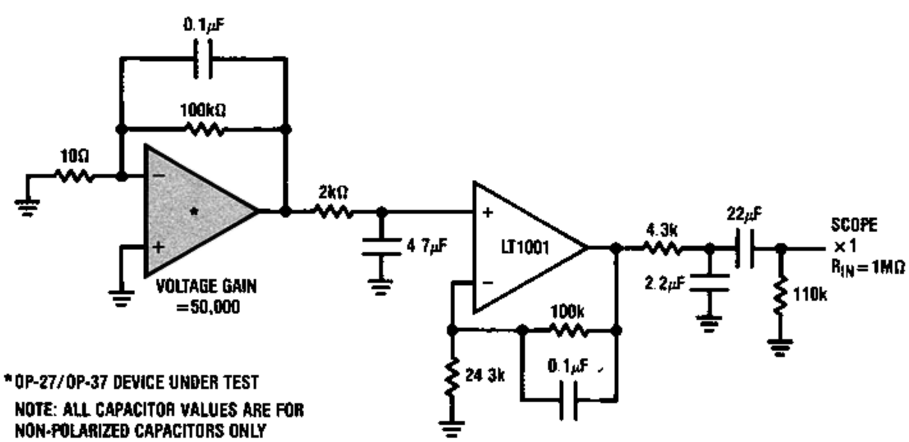
A noise-voltage density test is recommended when measuring noise on a large number of units. A 10Hz noise-voltage density measurement will correlate well with a 0.1Hz to 10Hz peak-to-peak noise reading since both results are determined by the white noise and the location of the 1/f corner frequency.

Current noise is measured and calculated by the following formula:

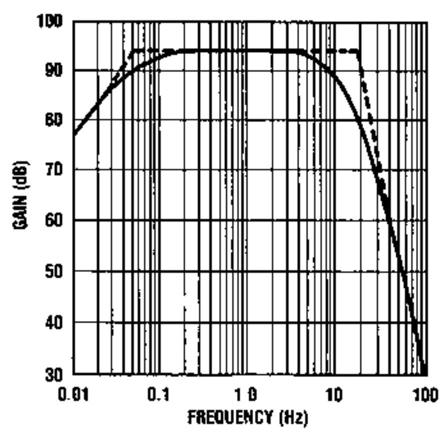
$$i_n = \frac{[e^2_{no} - (130nV)^2]^{1/2}}{1M\Omega \times 100}$$



0.1Hz to 10Hz Noise Test Circuit



0.1Hz to 10Hz p-p Noise Tester Frequency Response

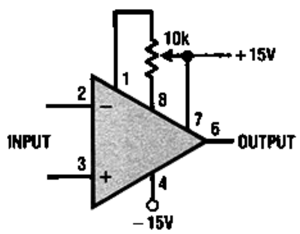


APPLICATIONS INFORMATION

Offset Voltage Adjustment

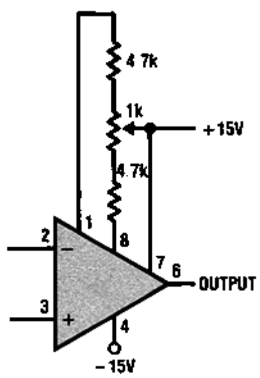
The input offset voltage of the OP-27/37, and its drift with temperature, are permanently trimmed at wafer testing to a low level. However, if further adjustment of V_{OS} is necessary, the use of a 10k nulling potentiometer will not degrade drift with temperature. Trimming to a value other than zero creates a drift of $(V_{OS}/300)$ $\mu V/°C$, e.g., if V_{OS} is adjusted to $300\mu V$, the change in drift will be $1\mu V/°C$.

Standard Adjustment



The adjustment range with a 10k pot is approximately $\pm 2.5mV$. If less adjustment range is needed, the sensitivity and resolution of the nulling can be improved by using a smaller pot in conjunction with fixed resistors. The example has an approximate null range of $\pm 200\mu V$.

Improved Sensitivity Adjustment

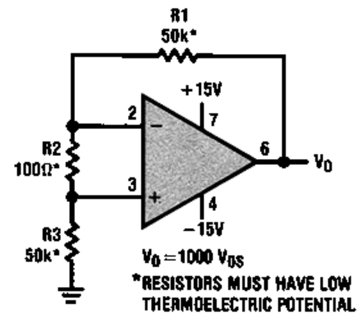


Offset Voltage and Drift

Thermocouple effects, caused by temperature gradients across dissimilar metals at the contacts to the input terminals, can exceed the inherent drift of the amplifier unless proper care is exercised. Air currents should be minimized, package leads should be short, the two input leads should be close together and maintained at the same temperature.

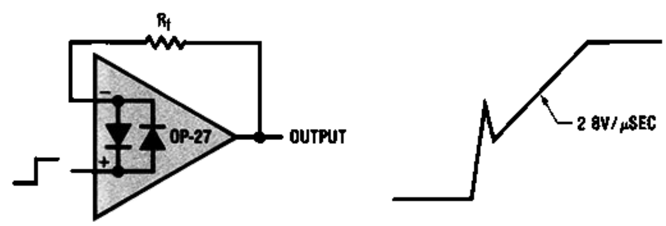
The circuit shown to measure offset voltage is also used as the burn-in configuration for the OP-27/37, with the supply voltages increased to $\pm 20V$, $R1 = R3 = 10k$, $R2 = 200\Omega$, $A_V = 100$.

Test Circuit for Offset Voltage and Offset Voltage Drift with Temperature



Unity Gain Buffer Applications (OP-27 Only)

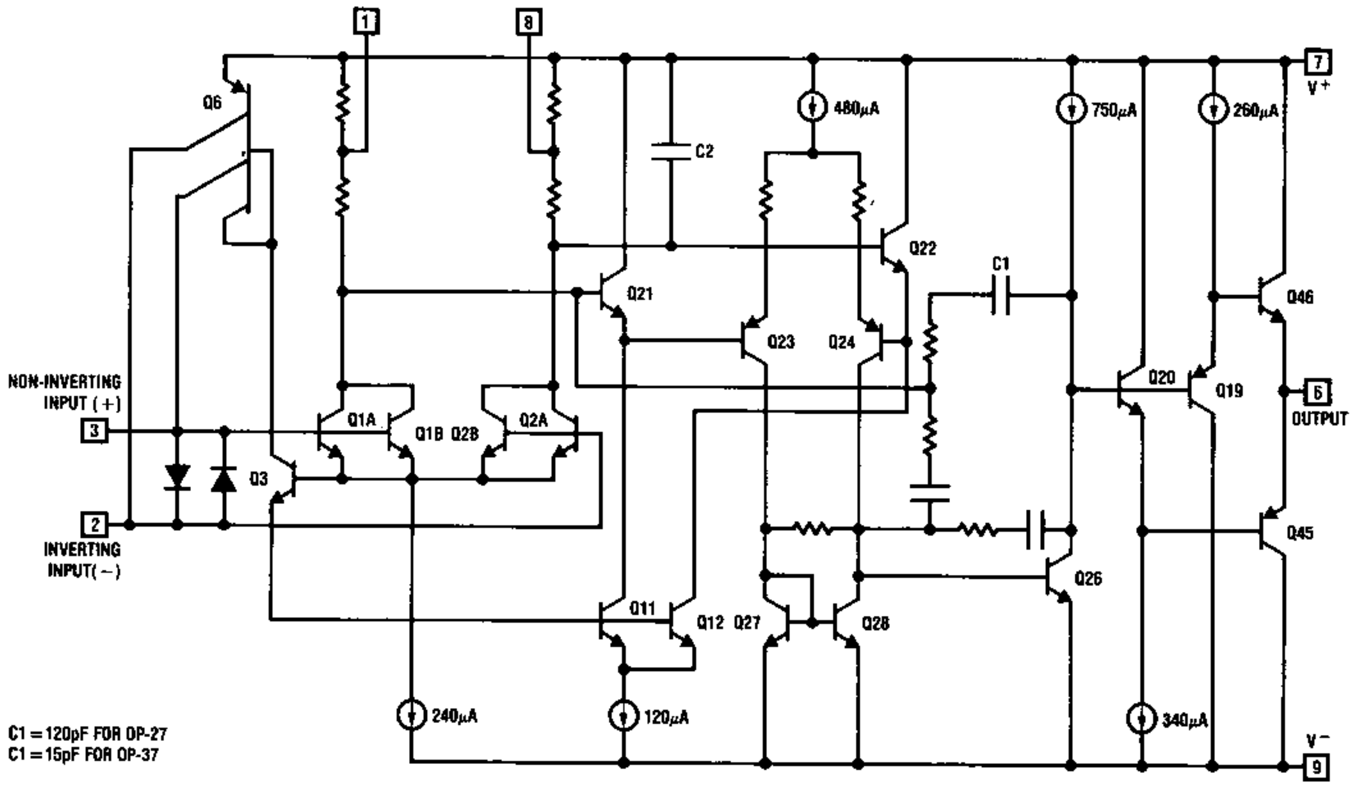
When $R_f \leq 100\Omega$ and the input is driven with a fast, large signal pulse ($>1V$), the output waveform will look as shown in the pulsed operation diagram.



During the fast feedthrough-like portion of the output, the input protection diodes effectively short the output to the input and a current, limited only by the output short circuit protection, will be drawn by the signal generator. With $R_f \geq 500\Omega$, the output is capable of handling the current requirements ($I_L \leq 20mA$ at 10V) and the amplifier stays in its active mode and a smooth transition will occur.

As with all operational amplifiers when $R_f > 2k\Omega$, a pole will be created with R_f and the amplifier's input capacitance, creating additional phase shift and reducing the phase margin. A small capacitor (20pF to 50pF) in parallel with R_f will eliminate this problem.

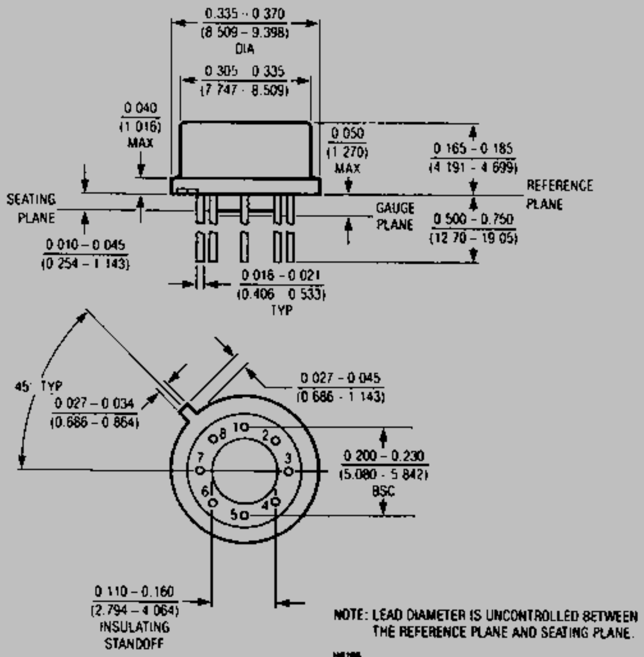
SCHEMATIC DIAGRAM



C1 = 120pF FOR OP-27
C1 = 15pF FOR OP-37

PACKAGE DESCRIPTION

H Package
Metal Can

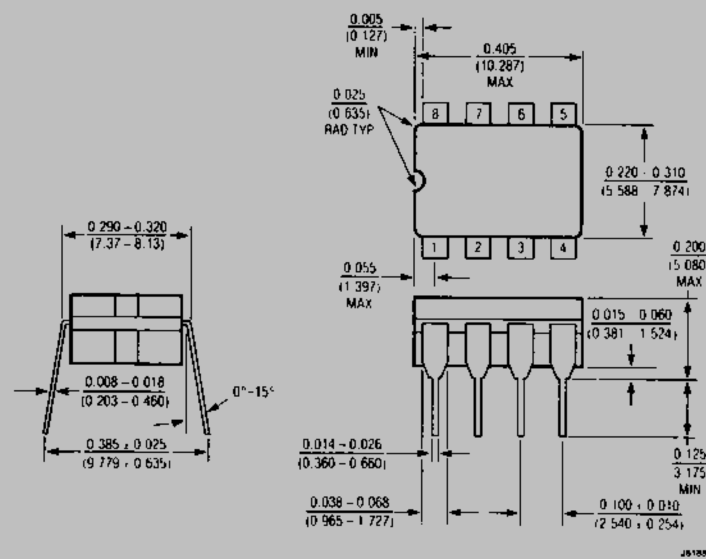


NOTE: DIMENSIONS IN INCHES (MILLIMETERS)

$T_J$max	θ_{ja}	θ_{jc}
150°C	150°C/W	45°C/W

OBSOLETE PACKAGE

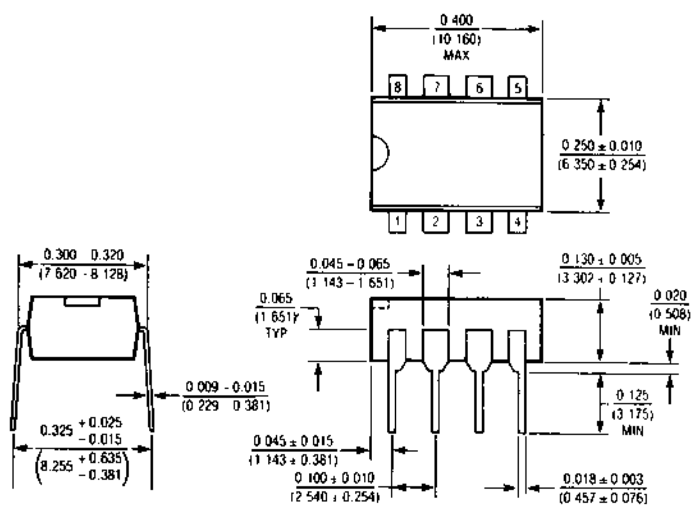
J8 Package
8 Lead Hermetic DIP



NOTE: DIMENSIONS IN INCHES (MILLIMETERS) UNLESS OTHERWISE NOTED
***LEADS WITHIN 0.007 OF TRUE POSITION (TP) AT GAUGE PLANE**

$T_J$max	θ_{ja}
150°C	100°C/W

N8 Package
8 Lead Plastic



NOTE: DIMENSIONS IN INCHES UNLESS OTHERWISE NOTED
***LEADS WITHIN 0.007 OF TRUE POSITION (TP) AT GAUGE PLANE**

$T_J$max	θ_{ja}
100°C	130°C/W

NOTES

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